Unit: mm

TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT process)

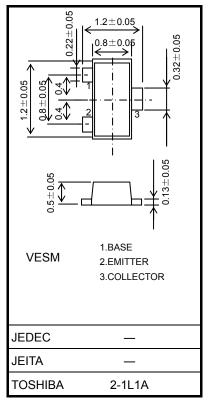
# 2SA1955FV

General Purpose Amplifier Applications Switching and Muting Switch Application

- Low saturation voltage: V<sub>CE (sat)</sub> (1) = -15 mV (typ.)
- @I<sub>C</sub> = –10 mA/I<sub>B</sub> = –0.5 mA
- Large collector current:  $I_C = -400 \text{ mA} \text{ (max)}$

### Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Collector-base voltage	V <sub>CBO</sub>	-15	V	
Collector-emitter voltage	V <sub>CEO</sub>	-12	V	
Emitter-base voltage	V <sub>EBO</sub>	-5	V	
Collector current	Ι <sub>C</sub>	-400	mA	
Base current	Ι <sub>Β</sub>	-50	mA	
Collector power dissipation	P <sub>C</sub>	150 *	mW	
Junction temperature	Tj	150	°C	
Storage temperature range	T <sub>stg</sub>	-55~150	°C	

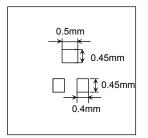


Weight: 0.0015g (typ.)

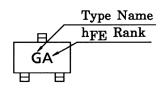
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

\* : Mounted on FR4 board (25.4 mm  $\times$  25.4 mm  $\times$  1.6mmt)



### Marking

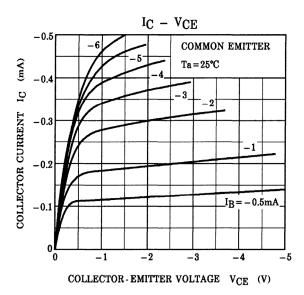


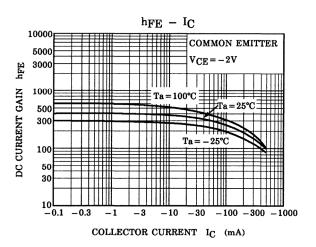
Electrical Characteristics (Ta = 25°C)

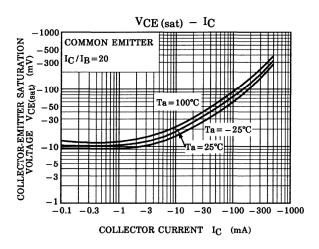
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off c	current	I <sub>CBO</sub>	$V_{CB} = -15 V, I_E = 0$	_	_	-0.1	μA
Emitter cut-off cur	rrent	I <sub>EBO</sub>	$V_{EB} = -5 V, I_C = 0$	_	_	-0.1	μA
DC current gain		h <sub>FE</sub> (Note)	$V_{CE} = -2 V, I_C = -10 mA$	300	_	1000	
Collector-emitter saturation voltage		V <sub>CE (sat) (1)</sub>	$I_{C} = -10 \text{ mA}, I_{B} = -0.5 \text{ mA}$	_	-15	-30	mV
		V <sub>CE (sat) (2)</sub>	$I_{C} = -200 \text{ mA}, I_{B} = -10 \text{ mA}$	_	-110	-250	
Base-emitter satu	iration voltage	V <sub>BE (sat)</sub>	$I_{C} = -200 \text{ mA}, I_{B} = -10 \text{ mA}$	_	-0.87	-1.2	V
Transition frequency		f <sub>T</sub>	$V_{CE} = -2 V, I_C = -10 mA$	80	130	_	MHz
Collector output capacitance		C <sub>ob</sub>	$V_{CB} = -10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz}$	_	4.2	_	pF
Collector-emitter on resistance		R <sub>on</sub>	$I_B = -1 \text{ mA}, V_{in} = -1 V_{rms}, f = 1 \text{ kHz}$	_	0.9	_	Ω
Switching time Stor	Turn-on time	t <sub>on</sub>		_	40	_	
	Storage time	t <sub>stg</sub>	$ \begin{array}{c}                                     $		280		ns
	Fall time	t <sub>f</sub>	=3V = -6V $I_{B1} = -I_{B2} = 5 \text{ mA}$		45		

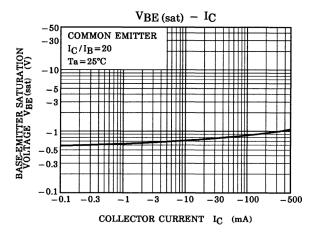
Note: hFE classification A: 300~600, B: 500~1000

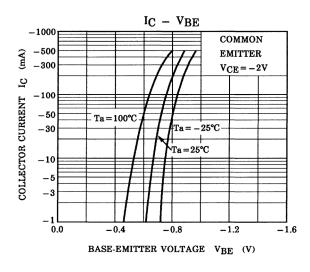
## <u>TOSHIBA</u>

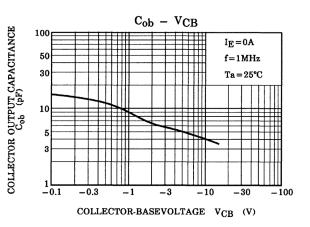




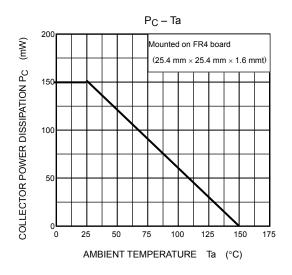








### **TOSHIBA**



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20070701-EN GENERAL

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